


<b>Search Notes</b>  	<b>Application/Control No.</b>  10079992	<b>Applicant(s)/Patent Under Reexamination</b>  YAP ET AL.
	<b>Examiner</b>  Hasan, Syed Y	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
348	423.1	12/8/2006	Syed Y. Hasan
348	425.4	12/8/2006	Syed Y. Hasan
348	466	12/8/2006	Syed Y. Hasan
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SEARCH NOTES		
Search Notes	Date	Examiner
USPAT, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB	12/8/2006	Syed Y. Hasan
Consultation with Thai Tran	12/7/2006	Syed Y. Hasan
Consultation with Vincent Boccio	12/7/2006	Syed Y. Hasan
Consultation with James Fletcher	12/6/2006	Syed Y. Hasan

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner